1 General description

The BGS8H2 is a Low-Noise Amplifier (LNA) with bypass switch for LTE receiver applications, available in a small plastic 6-pin extremely thin leadless package. The BGS8H2 requires one external matching inductor.

The BGS8H2 delivers system-optimized gain for both primary and diversity applications where sensitivity improvement is required. The high linearity of these low noise devices ensures the required receive sensitivity independent of cellular transmit power level in FDD (Frequency Division Duplex) systems. When receive signal strength is sufficient, the BGS8H2 can be switched off to operate in bypass mode at a 1 μ A current, to lower power consumption.

The BGS8H2 is optimized for 2300 MHz to 2690 MHz.

2 Features and benefits

- Operating frequency from 2300 MHz to 2690 MHz
- Noise figure = 1.0 dB
- Gain 12.5 dB
- Bypass switch insertion loss of 2.3 dB
- High input 1 dB compression point of -1.5 dBm
- High in band IP3_i of 4.0 dBm
- Supply voltage 1.5 V to 3.1 V
- · Self-shielding package concept
- · Integrated supply decoupling capacitor
- Optimized performance at a supply current of 5.8 mA
- Power-down mode current consumption < 1 μA
- Integrated temperature stabilized bias for easy design.
- · Requires only one input matching inductor
- Input and output DC decoupled
- ESD protection on all pins (HBM > 2 kV)
- Integrated matching for the output
- Available in 6-pins leadless package 1.1 mm x 0.7 mm x 0.37 mm; 0.4 mm pitch: SOT1232
- 180 GHz transit frequency SiGe:C technology
- · Moisture sensitivity level 1



SiGe:C low-noise amplifier MMIC with bypass switch for LTE

3 Applications

- LNA for LTE reception in smart phones
- Feature phones
- Tablet PCs
- · RF front-end modules

SiGe:C low-noise amplifier MMIC with bypass switch for LTE

Quick reference data

Table 1. Quick reference data

f = 2350 MHz, V_{CC} = 2.8 V, $V_{I(CTRL)} \ge$ 0.8 V, and T_{amb} = 25 °C. Input matched to 50 Ω using a 2.7 nH inductor in series. Unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{CC}	supply voltage	RF input AC coupled	[1]	1.5	-	3.1	V
I _{CC}	supply current	in gain mode		3.8	5.8	7.8	mA
		in bypass mode; V _{I(CTRL)} < 0.3 V		-	-	1	μΑ
Gp	power gain	in gain mode; f = 2350 MHz	[2][3]	10.5	12.5	14.5	dB
		in bypass mode; f = 2350 MHz	[2][3]	-3.8	-2.3	-0.8	dB
NF	noise figure	in gain mode; f = 2350 MHz	[2][3][4]	-	1.0	1.5	dB
P _{i(1dB)}	input power at 1 dB gain compression	in gain mode; f = 2350 MHz		-5.5	-1.5	-	dBm
IP3 _i	input third-order intercept point	in gain mode; f = 2350 MHz	[2][3]	-1.0	+4.0	-	dBm

- Stressed with pulses of 1 s in duration. V_{CC} connected to a power supply of 2.8 V with 500 mA current limit. E-UTRA operating band 40 (2300 MHz to 2400 MHz).
- Guaranteed by device design; not tested in production.
- PCB losses are subtracted.

Ordering information 5

Table 2. Ordering information

Table 2. Ordering information							
Type number	Package						
	Name	Description	Version				
BGS8H2	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1.1 x 0.7 x 0.37 mm	SOT1232				
OM17007	EVB	BGS8H2 evaluation board	-				

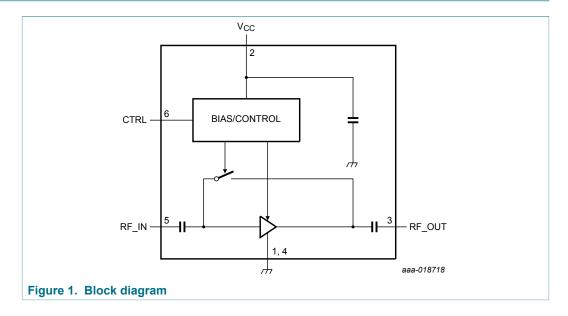
Marking 6

Table 3. Marking code

Type number	Marking code
BGS8H2	P

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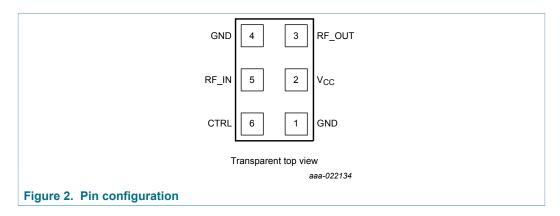
7 Block diagram



SiGe:C low-noise amplifier MMIC with bypass switch for LTE

8 Pinning information

8.1 Pinning



8.2 Pin description

Table 4. Pinning

- unit in					
Symbol	Pin	Description			
GND	1	ground			
V _{CC}	2	supply voltage			
RF_OUT	3	RF out			
GND_RF	4	ground RF			
RF_IN	5	RF in			
CTRL	6	gain control, switch between gain and bypass mode			

SiGe:C low-noise amplifier MMIC with bypass switch for LTE

Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

See legal section: "disclaimers" paragraph "Limiting values".

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage	RF input AC coupled	[1]	-0.5	+5.0	V
V _{I(CTRL)}	input voltage on pin CTRL	$V_{I(CTRL)} < V_{CC} + 0.6 V$	[1][2]	-0.5	+5.0	V
V _{I(RF_IN)}	input voltage on pin RF_IN	DC; V _{I(RF_IN)} < V _{CC} + 0.6 V		-0.5	+5.0	V
V _{I(RF_OUT)}	input voltage on pin RF_OUT	DC; V _{I(RF_OUT)} < V _{CC} + 0.6 V	[1][2][3]	-0.5	+5.0	V
Pi	input power		[1]	-	26	dBm
P _{tot}	total power dissipation	T _{sp} ≤ 130 °C		_	55	mW
T _{stg}	storage temperature			-65	+150	°C
Tj	junction temperature			-	150	°C
V _{ESD}	electrostatic discharge voltage	Human Body Model (HBM) according to ANSI/ESDA/JEDEC standard JS-001		-	±2	kV
		Charged Device Model (CDM) according to JEDEC standard JESD22-C101C		-	±1	kV

10 Recommended operating conditions

Table 6. Operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CC}	supply voltage	[1]	1.5	-	3.1	V
T _{amb}	ambient temperature		-40	+25	+85	°C
V _{I(CTRL)}	input voltage on pin CTRL	OFF state	-	-	0.3	V
		ON state	0.8	-	V _{cc}	V

^[1] Stressed with pulses of 1 s in duration. V_{CC} connected to a power supply with 500 mA current limit.

11 Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		225	K/W

BGS8H2

Stressed with pulses of 1 s in duration. V_{CC} connected to a power supply of 2.8 V with 500 mA current limit. Warning: Due to internal ESD diode protection, to avoid excess current, the applied DC voltage must not exceed V_{CC} + 0.6 V or 5.0 V. The RF input and RF output are AC coupled through internal DC blocking capacitors.

SiGe:C low-noise amplifier MMIC with bypass switch for LTE

12 Characteristics

Table 8. Characteristics at V_{CC} = 1.8 V

2300 MHz \leq f \leq 2690 MHz, V_{CC} = 1.8 V, $V_{I(CTRL)}$ \geq 0.8 V and T_{amb} = 25 °C. Input matched to 50 Ω using a 2.7 nH inductor in series. Unless otherwise specified.

Symb ol	Parameter	Conditions		Min	Тур	Max	Unit
Δφ	phase variation	e variation between gain mode and bypass mode					
		f = 2350 MHz	[1]	-8	-	+8	deg
		f = 2655 MHz		-	-	-	deg
Gain m	ode						1
I _{CC}	supply current			3.6	5.6	7.6	mA
Gp	power gain	f = 2350 MHz	[1] [2]	10.0	12.0	14.0	dB
		f = 2500 MHz		9.3	11.3	13.3	dB
		f = 2655 MHz	[1] [3]	8.5	10.5	12.5	dB
RLin	input return loss	f = 2350 MHz	[2]	-	7.5	-	dB
		f = 2655 MHz	[3]	-	8.0	-	dB
RLout	output return loss	f = 2350 MHz	[2]	-	9.0	-	dB
		f = 2655 MHz	[3]	-	7.0	-	dB
ISL	isolation	f = 2350 MHz	[2]	-	22.0	-	dB
		f = 2655 MHz	[3]	-	22.0	-	dB
NF	noise figure	f = 2350 MHz	[1] [2] [4]	-	1.05	1.5	dB
		f = 2655 MHz	[1] [3] [4]	-	1.15	1.6	dB
P _{i(1dB)}	nput power at 1 dB gain	f = 2350 MHz	[1] [2]	-9.5	-5.5	-	dBm
	compression	f = 2655 MHz	[1] [2]	-8.5	-4.5	-	dBm
IP3 _i	input third-order intercept	f = 2350 MHz	[1] [2]	-2	+3.0	-	dBm
	point	f = 2655 MHz	[1] [3]	-2	+3.0	-	dBm
K	Rollett stability factor			1	-	-	-
t _{on}	turn-on time	time from V _{I(CTRL)} ON, to 90 % of the gain		-	-	1.7	μs
t _{off}	turn-off time	time from V _{I(CTRL)} OFF, to 10 % of the gain		-	-	0.6	μs
Bypass	mode						
I _{CC}	supply current	V _{I(CTRL)} < 0.3 V		-	-	1	μΑ
G _p	power gain	f = 2350 MHz	[1] [2]	-3.9	-2.4	-0.9	dB
		f = 2500 MHz	[1]	-4.5	-2.6	-1.1	dB
		f = 2655 MHz	[1] [2]	-4.2	-2.7	-1.2	dB
RLin	input return loss	f = 2350 MHz	[2]	-	12.0	-	dB
		f = 2655 MHz	[3]	-	11.0	-	dB
RL _{out}	output return loss	f = 2350 MHz	[2]	-	11.0	-	dB
		f = 2655 MHz	[3]	-	11.0	-	dB

BGS8H2

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SiGe:C low-noise amplifier MMIC with bypass switch for LTE

- Guaranteed by device design; not tested in production.
- E-UTRA operating band 40 (2300 MHz to 2400 MHz). E-UTRA operating band 7 (2620 MHz to 2690 MHz). PCB losses are subtracted.

Table 9. Characteristics at V_{CC} = 2.8 V

2300 MHz \leq f \leq 2690 MHz, V_{CC} = 2.8 V, $V_{I(CTRL)}$ \geq 0.8 V and T_{amb} = 25 °C. Input matched to 50 Ω using a 2.7 nH inductor in series. Unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Δφ	phase variation	between gain mode and bypass mode					
		f = 2350 MHz	[1]	-8	-	+8	deg
		f = 2655 MHz		-	-	-	deg
Gain mo	de						
I _{CC}	supply current			3.8	5.8	7.8	mA
Gp	power gain	f = 2350 MHz	[1][2]	10.5	12.5	14.5	dB
		f = 2500 MHz		9.9	11.9	13.9	dB
		f = 2655 MHz	[1][3]	9.2	11.2	13.2	dB
RLin	input return loss	f = 2350 MHz	[2]	-	8.0	-	dB
		f = 2655 MHz	[3]	-	8.5	-	dB
RL _{out}	output return loss	f = 2350 MHz	[2]	-	10.0	-	dB
		f = 2655 MHz	[3]	-	7.0	-	dB
ISL	isolation	f = 2350 MHz	[2]	-	23.0	-	dB
		f = 2655 MHz	[3]	-	23.0	-	dB
NF	noise figure	f = 2350 MHz	[1][2][4]	-	1.00	1.5	dB
		f = 2655 MHz	[1][3][4]		1.10	1.6	dB
P _{i(1dB)}	input power at 1 dB gain	f = 2350 MHz	[1][2]	-5.5	-1.5	-	dBm
	compression	f = 2655 MHz	[1][3]	-4.0	0.0	-	dBm
IP3 _i	input third-order intercept point	f = 2350 MHz	[1][2]	-1.0	+4.0	-	dBm
		f = 2655 MHz	[1][3]	-1.0	+4.0	-	dBm
K	Rollett stability factor			1	-	-	
t _{on}	turn-on time	time from $V_{I(CTRL)}$ ON, to 90 % of the gain		-	-	1.3	μs
t _{off}	turn-off time	time from V _{I(CTRL)} OFF, to 10 % of the gain		-	-	0.3	μs

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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Bypass	mode		'				
I _{CC}	supply current	V _{I(CTRL)} < 0.3 V		-	-	1	μΑ
Gp	power gain	f = 2350 MHz	[1][2]	-3.8	-2.3	-0.8	dB
		f = 2500 MHz	[1]	-4.5	-2.4	-0.9	dB
		f = 2655 MHz	[1][3]	-4.0	-2.5	-1.0	dB
RLin	input return loss	f = 2350 MHz	[2]	-	12.0	-	dB
		f = 2655 MHz	[3]	-	12.0	-	dB
RL _{out}	output return loss	f = 2350 MHz	[2]	-	12.0	-	dB
		f = 2655 MHz	[3]	-	12.0	-	dB

Guaranteed by device design; not tested in production. E-UTRA operating band 40 (2300 MHz to 2400 MHz). E-UTRA operating band 7 (2620 MHz to 2690 MHz). PCB losses are subtracted. [1] [2] [3] [4]

SiGe:C low-noise amplifier MMIC with bypass switch for LTE

13 Application information

13.1 LTE LNA

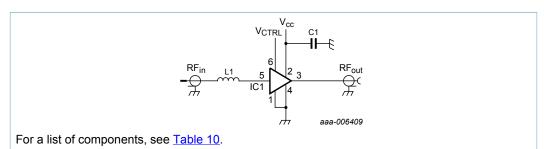


Figure 3. Schematics LTE LNA evaluation board

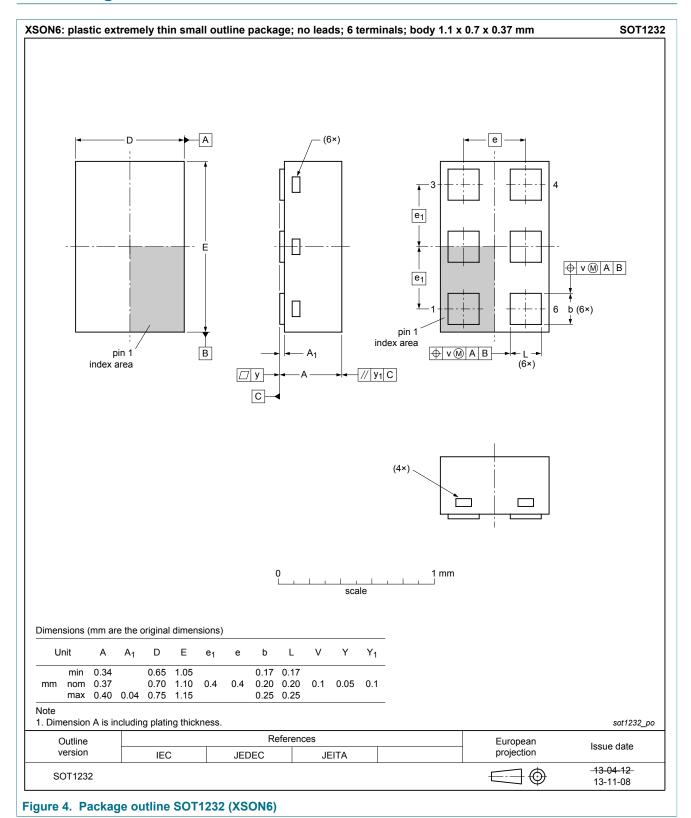
Table 10. List of components

For schematics, see Figure 3.

Component	Description	Value	Remarks
C1	decoupling capacitor	1 μF	to suppress power supply noise
IC1	BGS8H2	-	NXP Semiconductors
L1	high-quality matching inductor	2.7 nH	Murata LQW15A

SiGe:C low-noise amplifier MMIC with bypass switch for LTE

14 Package outline



SiGe:C low-noise amplifier MMIC with bypass switch for LTE

15 Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices. Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A*, or equivalent standards.

16 Abbreviations

Table 11. Abbreviations

Tuble 11. Appleviations				
Acronym	Description			
ESD	ElectroStatic Discharge			
НВМ	Human Body Model			
LTE	Long-Term Evolution			
MMIC	Monolithic Microwave Integrated Circuit			
PCB	Printed-Circuit Board			
SiGe:C	Silicon Germanium Carbon			

17 Revision history

Table 12. Revision history

Table 12. Revision history							
Document ID	Release date	Data sheet status	Change notice	Supersedes			
BGS8H2 v.4	20180820	Product data sheet	-	BGS8H2 v.3			
Modifications:	changed status from company confidential to public						
BGS8H2 v.3	20180629	Product data sheet	-	BGS8H2 v.2			
Modifications:	changed $V_{I(CTRL)}$ Max ON state value to V_{cc} at recommended operating conditions						
BGS8H2 v.2	20160404	Product data sheet	-	BGS8H2 v.1			
Modifications:	added phase variation <u>Table 8 on page 5</u> and <u>Table 9 on page 6</u>						
BGS8H2 v.1	20151222	Product data sheet	-	-			

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18 Legal information

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SiGe:C low-noise amplifier MMIC with bypass switch for LTE

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